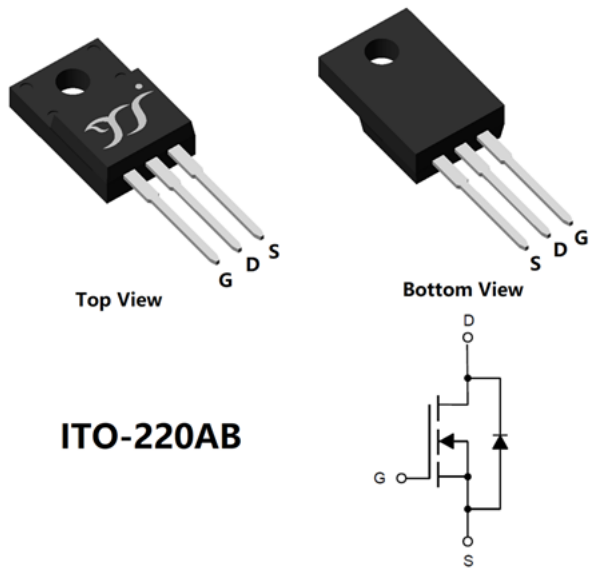


N-Channel Enhancement Mode Field Effect Transistor



Product Summary

- V_{DS} 650V
- I_D 4.3A
- $R_{DS(ON)}$ (at $V_{GS}=10V$) $<960m\Omega$
- 100% EAS Tested
- 100% ∇V_{DS} Tested

General Description

- Super Junction High Voltage MOSFET technology
- Ultra Low Gate Charge Cause Lower Driving Requirement
- Low On-resistance and Low Conduction Loss
- Epoxy Meets UL 94 V-0 Flammability Rating
- Halogen Free

Applications

- Switching Mode Power Supplies (SMPS)
- PWM Motor Controls
- LED Lighting
- Adapter

Limiting Values

Parameter	Conditions	Symbol	Min	Max	Unit	
Drain-source Voltage		V_{DS}	-	650	V	
Gate-source Voltage		V_{GS}	-30	30	V	
Continuous Drain Current (Note 1,2)	Steady-State	I_D	$T_A=25^\circ C, V_{GS}=10V$	-	0.92	A
			$T_A=100^\circ C, V_{GS}=10V$	-	0.58	
Continuous Drain Current (Note 1,3)	Steady-State		$T_C=25^\circ C, V_{GS}=10V$	-	4.3	
			$T_C=100^\circ C, V_{GS}=10V$	-	2.7	
Pulsed Drain Current	$T_C=25^\circ C, t_p \leq 10\mu s$	I_{DM}	-	15		
Maximum Body-Diode Continuous Current	$T_C=25^\circ C$	I_S		4.3		
Maximum Body-Diode Pulsed Current	$T_C=25^\circ C, t_p \leq 10\mu s$	I_{SM}	-	15		
Avalanche Energy (non-repetitive)	$T_J=25^\circ C, V_G=10V, R_G=25\Omega, L=30mH, I_{AS}=2.3A$	EAS	-	79.3	mJ	
Total Power Dissipation (Note 1,2)	Steady-State	P_D	$T_A=25^\circ C$	-	1.95	W
			$T_A=100^\circ C$	-	0.78	
Total Power Dissipation (Note 1,3)	Steady-State		$T_C=25^\circ C$	-	41.6	
			$T_C=100^\circ C$	-	16.6	
MOSFET dv/dt Ruggedness	$T_J=25^\circ C, V_{DS}=0 \dots 325V, I_D \leq 3.3A, R_G=0\Omega$	dv/dt	-	22.6	V/ns	
Reverse Diode dv/dt	$T_J=25^\circ C, V_{DS}=0 \dots 325V, I_D \leq 3.3A, di/dt=200A/\mu s$	dv/dt	-	7		
Maximum Diode Commutation Speed	$T_J=25^\circ C, V_{DS}=0 \dots 325V, I_D \leq 3.3A, R_G=0\Omega$	dif/dt	-	1375	A/ μs	
Insulation withstand voltage	$T_J=25^\circ C, V_{rms}, t=60s$	V_{ISO}	-	2.5	KV	
Junction and Storage Temperature Range		T_J, T_{STG}	-55	150	$^\circ C$	

Thermal Resistance

Parameter	Symbol	Typ	Max	Units
Thermal Resistance Junction-to-Ambient (Note 2)	$R_{\theta JA}$	-	64	$^\circ C/W$
Thermal Resistance Junction-to-Case	$R_{\theta JC}$	-	3	

Ordering Information (Example)

PREFERRED P/N	PACKING CODE	Marking	MINIMUM PACKAGE(pcs)	INNER BOX QUANTITY(pcs)	OUTER CARTON QUANTITY(pcs)	DELIVERY MODE
YJF960C65BHJ	B1	F960C65BHJ	50	/	5000	Tube



YJF960C65BHJ

■ Electrical Characteristics

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Static Parameter						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A, T_j=25^\circ C$	650	-	-	V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=650V, V_{GS}=0V, T_j=25^\circ C$	-	-	1	μA
		$V_{DS}=650V, V_{GS}=0V, T_j=150^\circ C$	-	-	100	
Gate-Source Leakage Current	I_{GSS}	$V_{GS}=\pm 30V, V_{DS}=0V, T_j=25^\circ C$	-	-	± 100	nA
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A, T_j=25^\circ C$	2.5	3.3	4.1	V
Static Drain-Source On-Resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=2A, T_j=25^\circ C$	-	760	960	m Ω
		$V_{GS}=10V, I_D=2A, T_j=150^\circ C$	-	1800	2270	
Diode Forward Voltage	V_{SD}	$I_S=4.3A, V_{GS}=0V, T_j=25^\circ C$	-	0.86	1.2	V
Gate Resistance	R_G	$f=1MHz, T_j=25^\circ C$	-	18	-	Ω
Dynamic Parameters						
Input Capacitance	C_{iss}	$V_{DS}=325V, V_{GS}=0V, f=1MHz, T_j=25^\circ C$	-	380	-	pF
Output Capacitance	C_{oss}		-	16	-	
Reverse Transfer Capacitance	C_{rss}		-	4.3	-	
Effective Output capacitance, Energy Related	$C_{o(er)}$	$V_{DS}=0\dots 325V, V_{GS}=0V, f=1MHz, T_j=25^\circ C$	-	22	-	
Effective Output Capacitance, Time Related	$C_{o(tr)}$		-	86	-	
Switching Parameters						
Total Gate Charge	Q_g	$V_{GS}=10V, V_{DS}=325V, I_D=4.3A, T_j=25^\circ C$	-	11.6	-	nC
Gate-Source Charge	Q_{gs}		-	2.1	-	
Gate-Drain Charge	Q_{gd}		-	5.7	-	
Reverse Recovery Charge	Q_{rr}	$I_F=4.3A, di/dt=100A/\mu s, V_{GS}=0V, V_R=325V, T_j=25^\circ C$	-	1710	-	nC
Reverse Recovery Time	t_{rr}		-	223	-	ns
Peak Reverse Recovery Current	I_{rrm}		-	14	-	A
Turn-on Delay Time	$t_{D(on)}$		$V_{GS}=10V, V_{DS}=325V, I_D=4.3A, R_{GEN}=3\Omega, T_j=25^\circ C$	-	21	-
Turn-on Rise Time	t_r	-		25	-	
Turn-off Delay Time	$t_{D(off)}$	-		30	-	
Turn-off Fall Time	t_f	-		28	-	

Note:

1. The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
2. The value of $R_{\theta JA}$ is measured in the still air environment with $T_A=25^\circ C$. The maximum allowed junction temperature of $150^\circ C$.
3. Thermal resistance from junction to soldering point (on the exposed drain pad).



Typical Electrical and Thermal Characteristics Diagrams

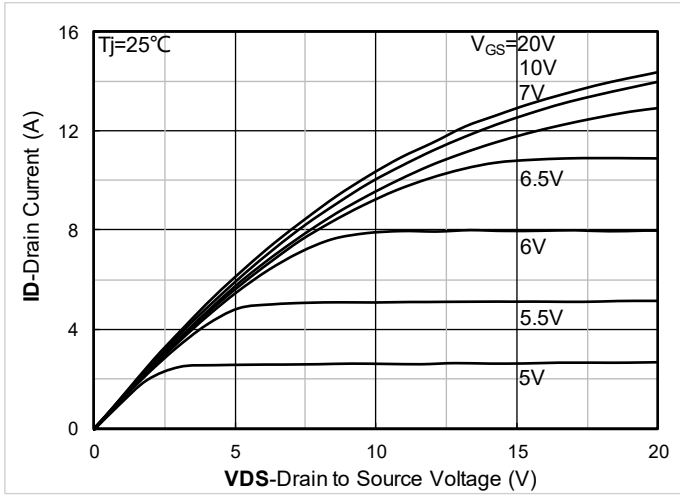


Figure 1. Output Characteristics; typical values

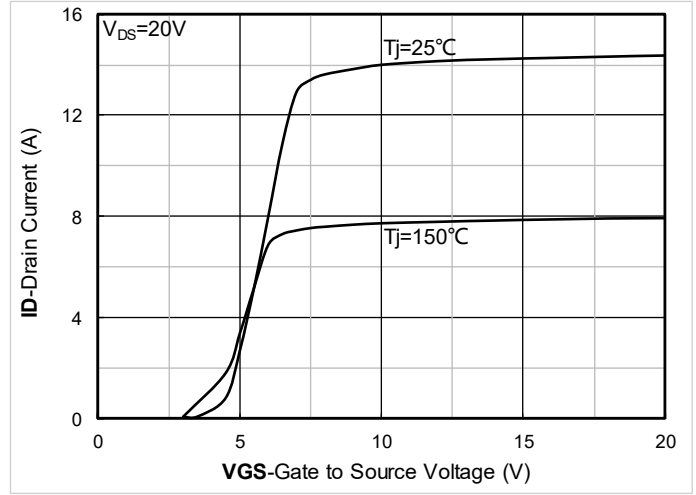


Figure 2. Transfer Characteristics; typical values

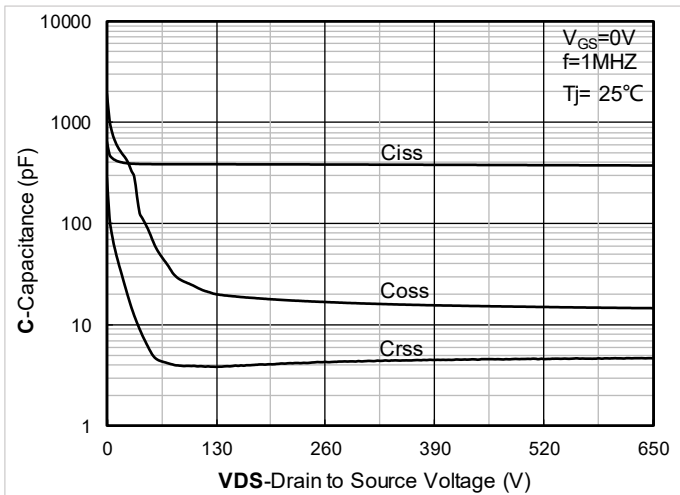


Figure 3. Capacitance Characteristics; typical values

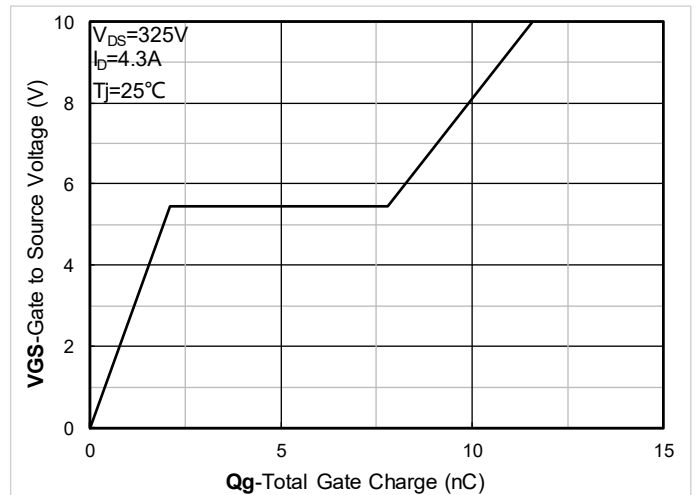


Figure 4. Gate Charge; typical values

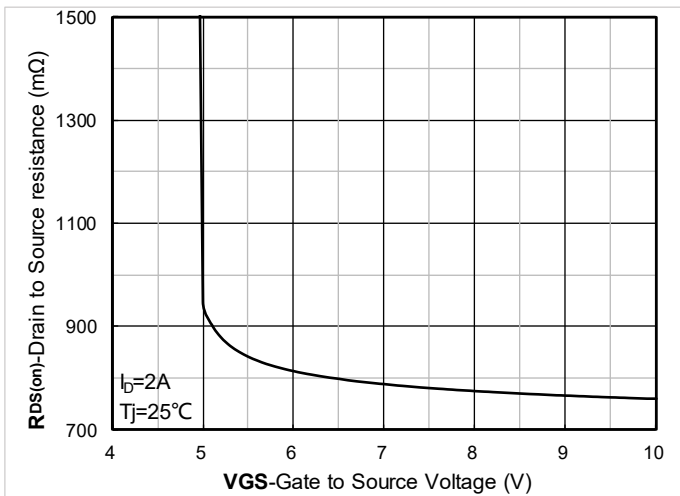


Figure 5. On-Resistance vs. Gate to Source Voltage; typical values

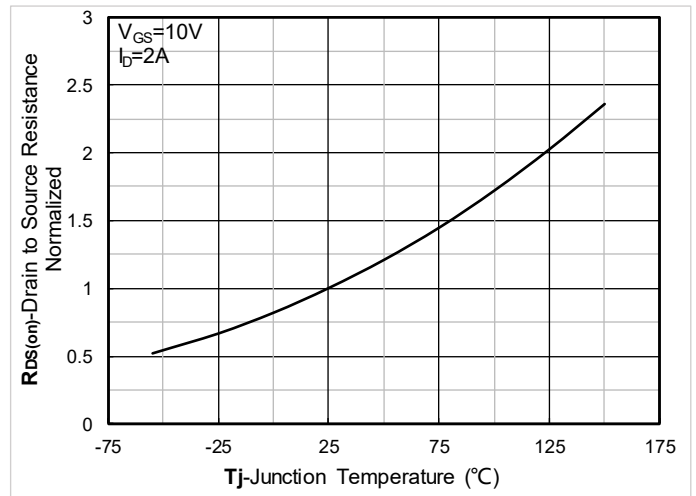


Figure 6. Normalized On-Resistance



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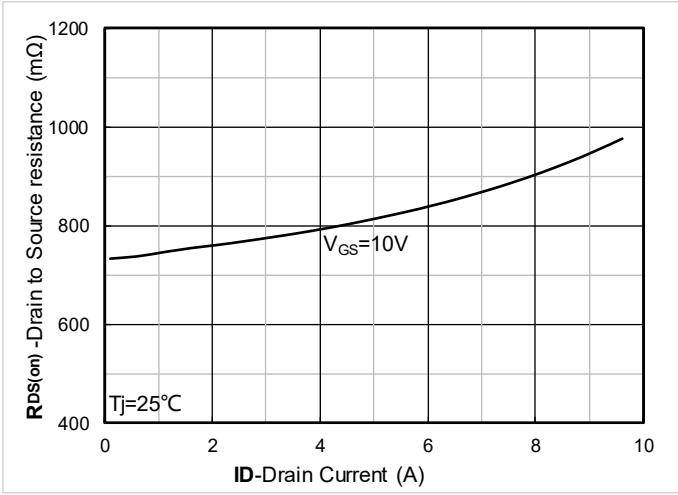


Figure 7. RDS(on) vs. Drain Current; typical values

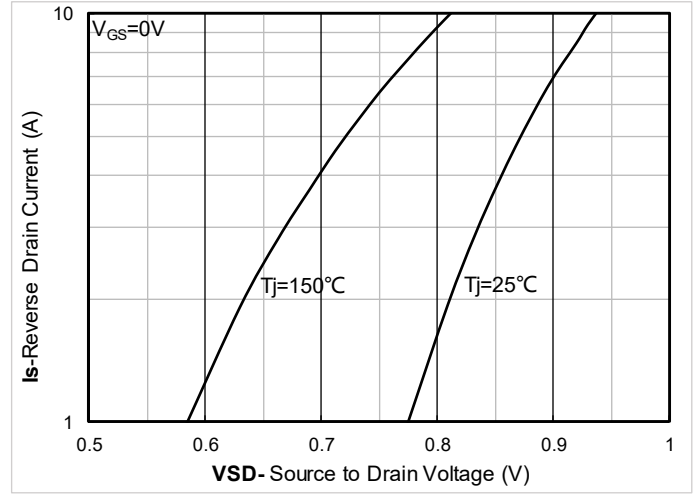


Figure 8. Forward characteristics of reverse diode; typical values

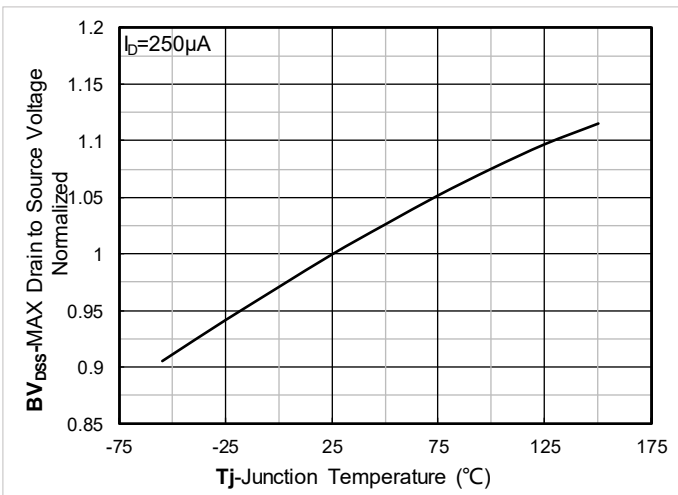


Figure 9. Normalized breakdown voltage

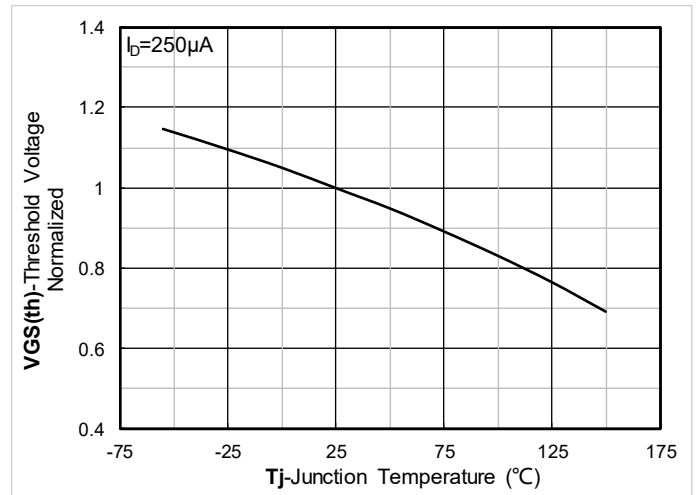


Figure 10. Normalized Threshold voltage

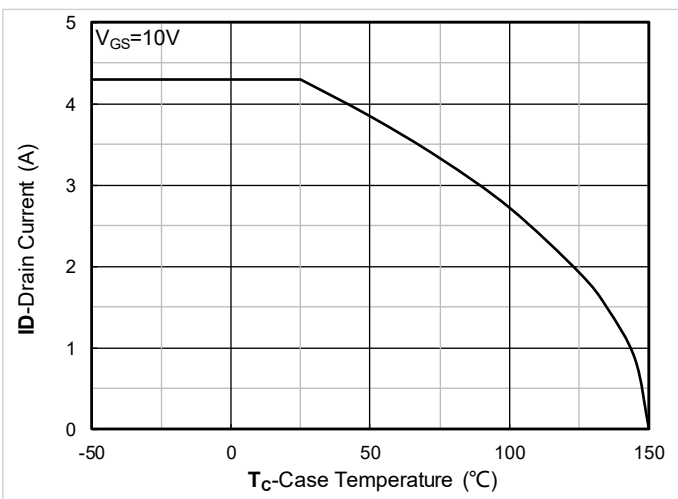


Figure 11. Current dissipation

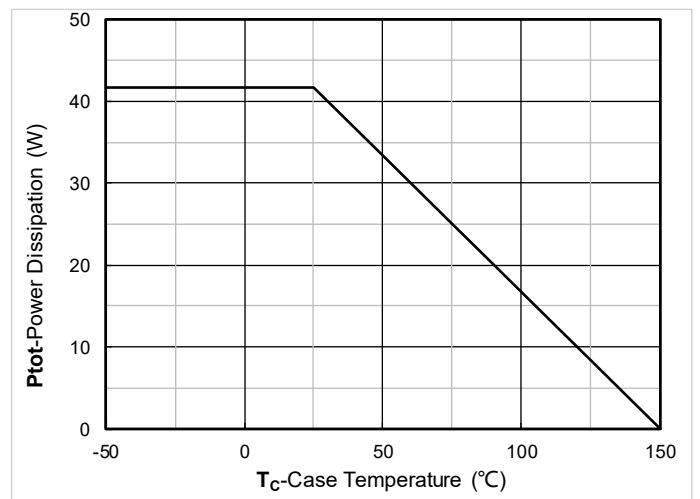


Figure 12. Power dissipation



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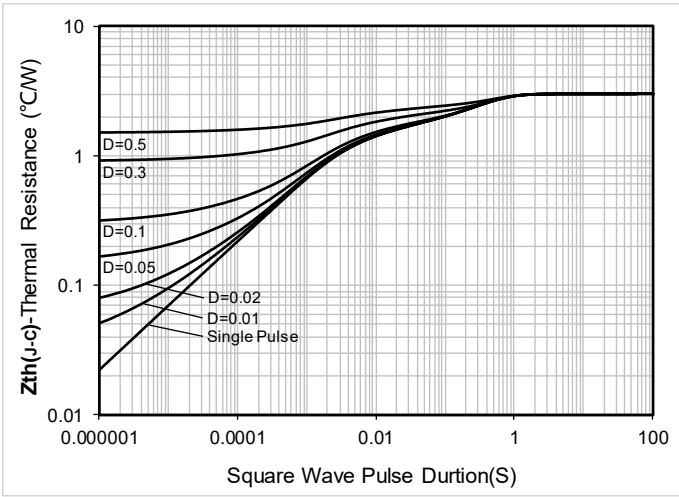


Figure 13. Maximum Transient Thermal Impedance

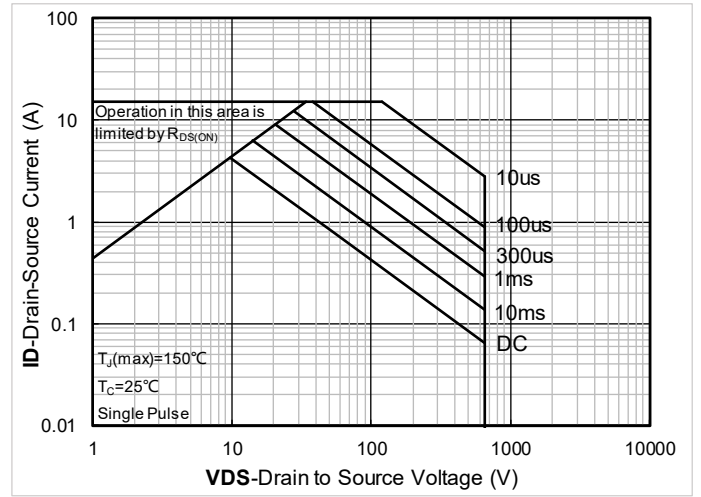


Figure 14. Safe Operation Area

■ Test Circuits & Waveforms

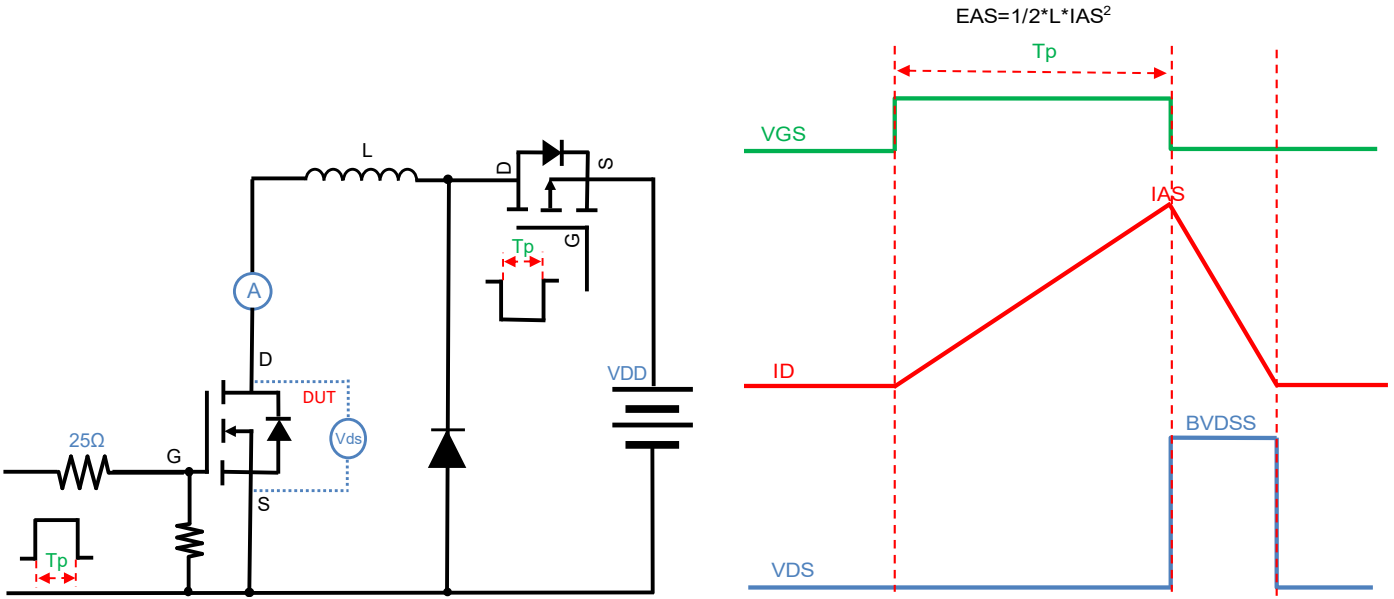


Figure A. Unclamped Inductive Switching (UIS) Test Circuit & Waveform

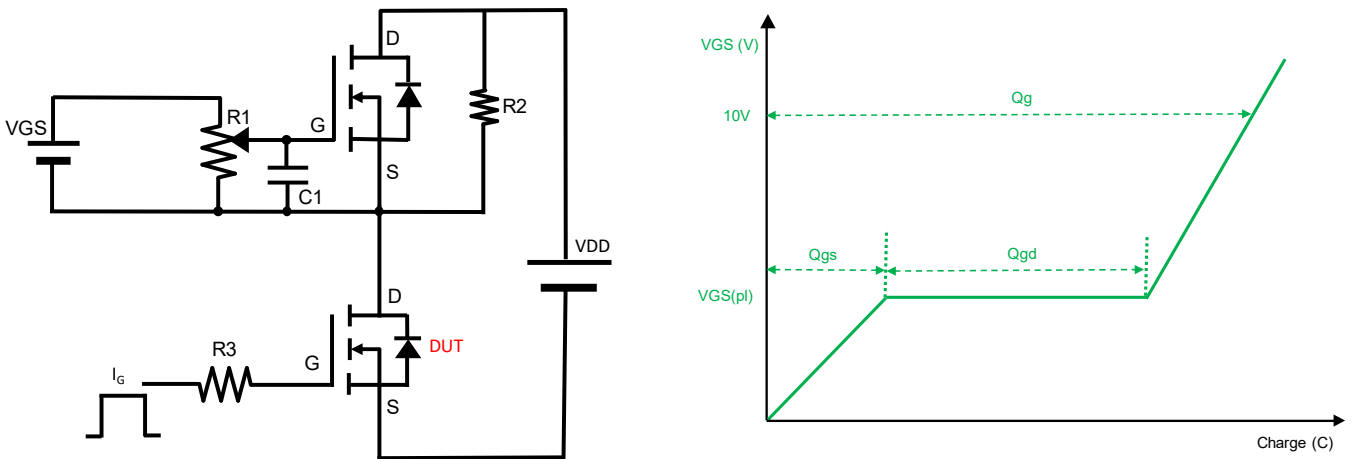


Figure B. Gate Charge Test Circuit & Waveform

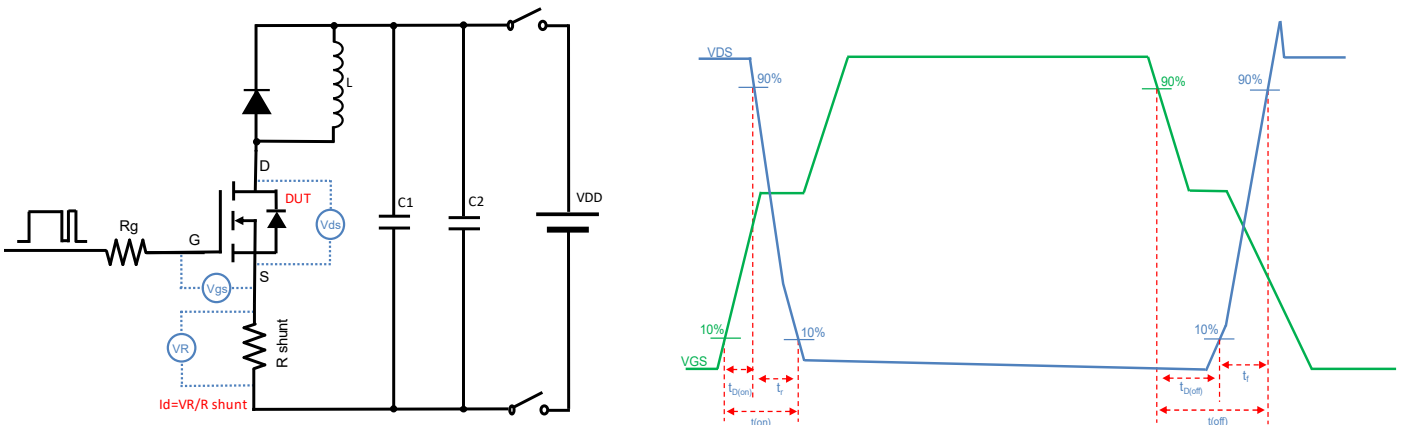


Figure C. Resistive Switching Test Circuit & Waveform

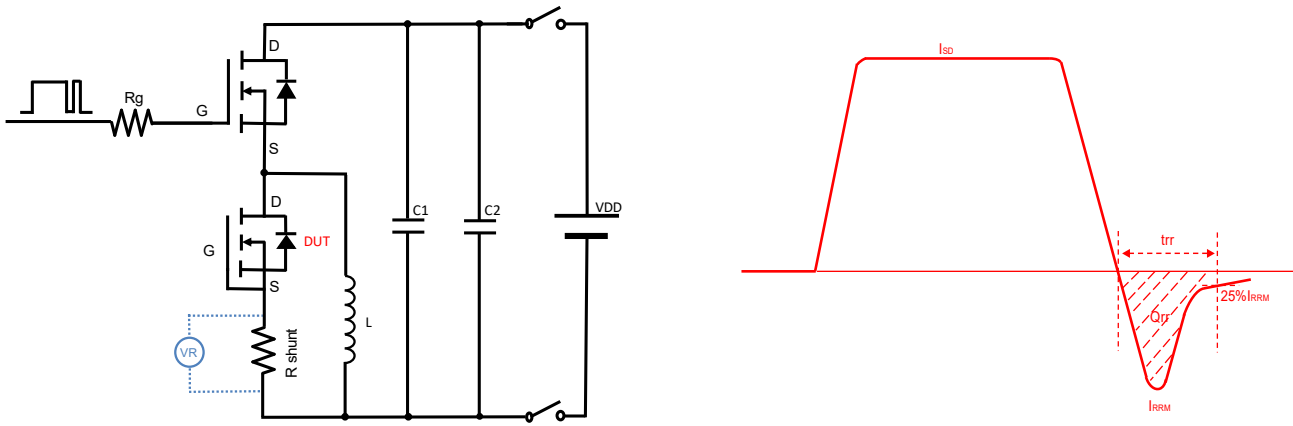
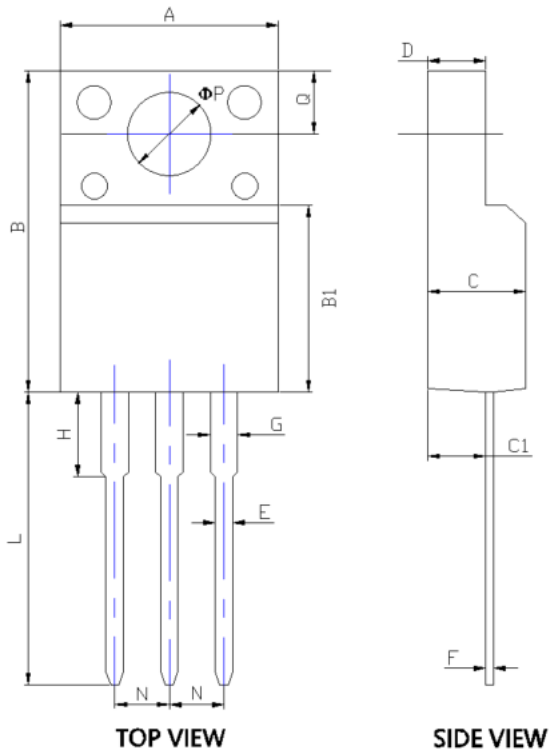


Figure D. Diode Recovery Test Circuit & Waveform



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■ ITO-220AB-E Package information



SYMBOL	DIMENSIONS			
	INCHES		Millimeter	
	MIN.	MAX.	MIN.	MAX.
A	0.390	0.406	9.900	10.300
B	0.610	0.633	15.500	16.100
B1	0.350	0.374	8.900	9.500
C	0.181	0.189	4.600	4.800
C1	0.087	0.110	2.200	2.800
D	0.096	0.104	2.450	2.650
E	0.028	0.035	0.700	0.900
F	0.016	0.024	0.400	0.600
G	0.044	0.056	1.120	1.420
H	0.134	0.150	3.400	3.800
L	0.496	0.512	12.600	13.000
N	0.100BSC.		2.540BSC.	
Q	0.126	0.142	3.200	3.600
ΦP	0.122	0.130	3.100	3.300

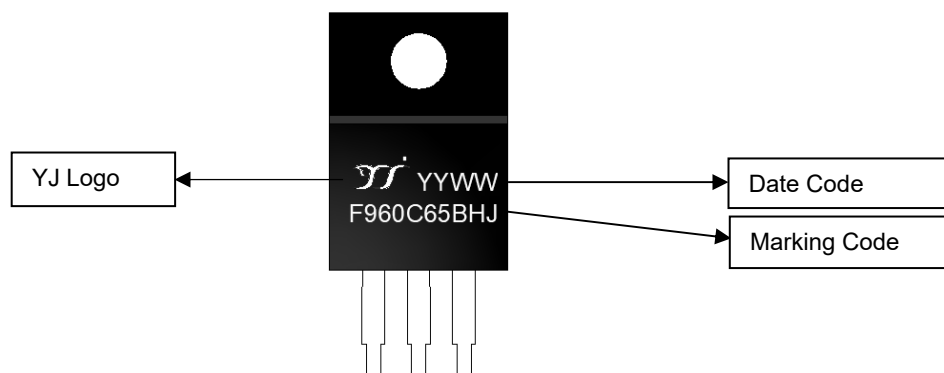
NOTE:

- 1.PACKAGE BODY SIZES EXCLUDE MOLD FLASH AND GATE BURRS.
- 2.TOLERANCE 0.1mm UNLESS OTHERWISE SPECIFIED.



YJF960C65BHJ

■ Marking Information



Note:

1. All marking is at middle of the product body
2. All marking is in laser printing
3. F960C65BHJ is marking code, YYWW is date code, "YY" is year, "WW" is week
4. Body color: Black



YJF960C65BHJ

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